An automated N-port network analyzer for linear and non-linear multi-port RF and digital circuits

Original

Availability:
This version is available at: 11583/2497915 since:

Publisher:
2497915

Published
DOI:10.1109/IMTC.1997.603912

Terms of use:
openAccess
This article is made available under terms and conditions as specified in the corresponding bibliographic description in the repository

Publisher copyright

(Article begins on next page)
An Automated N-Port Network Analyzer for Linear and Non Linear Multi-port RF and Digital Circuits

N. Boulejfen* , A. Ferrero†, F. M. Ghannouchi*, A. B. Kouki†

* Ecole Polytechnique de Montréal
3333 Queen Mary, R220.5
Montréal, PQ, Canada H3V 1A2

† Departmento di Elettronica Politecnico di Torino Torino
C. Duca degli Abruzzi 24 10124 Torino, Italy
Phone (514) 340 4872 Fax (514) 440 5892 E-Mail : nboulej@grmes.polymtl.ca

Abstract - A new automated N-port time and frequency domain network analyzer based on the microwave transition analyzer MTA, used as a high speed digital oscilloscope, has been developed. The validity of the developed system is demonstrated with number of experimental measurements on different multi-ports structures.

I. INTRODUCTION

The transients in modern communication switches and high-speed digital integrated circuits and complex subsystems are characterized by signal rise times shorter than one nanosecond. At such speed, efficient time domain characterization of such devices and circuits becomes more appropriate and highly desirable. Presently, most available instrumentation is devoted to the characterization of two-port devices, e.g., high frequency sampling oscilloscopes and network analyzers with time domain capability. However, the increasing complexity of commercial communication circuits requires novel techniques to characterize multi-port circuits such as high speed digital interconnects and three-port active devices.

II. PROPOSED SET UP

In this paper we present a time domain 4-port network analyzer and its application to multi-port circuits. The system, shown in figure 1, is based on use of the microwave transition analyzer (MTA HP 75100) which is configured as a broadband sampling oscilloscope from DC to 40 GHz. The source signal is routed to the various DUT ports via a source switching matrix. One of the two channels of the MTA receives a sample of the source signal and is used as a phase reference (trigger). The second channel receives in turn all the incident and reflected waves sampled with N 10 dB bi-directional couplers and routed via a receiver switching matrix as shown in figure 1.

This approach is easily expandable to N-ports by adding more channels into the two switching matrices and more couplers (one channel and one coupler by a DUT port). For non sinusoidal signal characterization, the DC components of the signal are measured separately via bias Tees. Although the bandwidth of the receiver covers up to 40 GHz, the built system is limited by the bandwidth of the couplers and switches used. In our application, couplers covering 1 MHz - 2 GHz are used. By means of the different modes of operation offered by the MTA, the developed system allows the following measurements.

A. S Parameter Measurements

In microwave frequencies, the passive linear N-port structures are well characterized by the S parameters, relating the incident and reflected waves at the ports as follows:

\[ B_i = \sum_{j=1}^{N} S_{ij} A_j \]  

(1)

where N is the number of ports, \( B_i \) and \( A_j \) are the reflected and the incident waves at the port i and port j respectively. From the equation (1) the entry \( S_{ij} \) of the S matrix are given by:
\[ S_{ij} = \frac{R_i}{A_j} \]  

where \( A_i \neq 0 \) when \( i \neq j \). It can be noted from equation (2) that the \( S_{ij} \) coefficients depend only on the ratios between waves and not on there absolute magnitudes and phases.

The measurement procedure start by configuring the MTA receiver in frequency sweep mode. At each frequency step, the MTA adjust the frequency of the RF source and switch it to one port of the device under test (DUT) at a time. Finally the MTA measure the magnitude and the phase of the ratio between the reference (channel 1) and one at a time of all the incident and reflected waves at the N ports of the DUT (channel 2). Once measured, the magnitudes and phases of the waves are used in equation (2) to compute the S matrix of the DUT. For calibration and de-embedding purposes, i.e., to transfer the measurement’s reference plane from the input channel of the MTA (channel 1) to the plane of the DUT, the calibration procedure used is based on a generalized TRL (thru-reflect-line) calibration for multi-port network analyzer described in [4]. In this calibration technique the coupling between ports is neglected. For on wafer measurements, this approach is not very accurate and a calibration based on a switching network’s leaky model is needed.

B. Time Domain Measurements

In the very large scale integration VLSI domain, the transient response measurement of the digital high speed interconnection is very important for characterizing the interconnection effect such as coupling, distortion, delay, etc. However, these structures propagate digital waves with wide frequency spectrum. To measure the transient response of such structure, the RF source is replaced by a pulse generator. The reference signal is then filtered using a band pass filter to obtain a sinusoidal signal with the fundamental frequency contained in the pulse frequency spectrum.

During the data acquisition process, the repetitive time domain sampling mode of the MTA is used. Up to 1024 samples can be obtained. The sampled data are Fourier transformed into the frequency domain for calibration and de-embedding purposes. The de-embedded and error-corrected data are then transformed back into the time domain. The calibration procedure used is based on the approach in [4] with the addition of an absolute amplitude and phase de-embedding step for time domain waveform reconstitution.

III. EXPERIMENTAL RESULTS

To validate and test the proposed test set, two tests are made. First, the S parameters of a commercial 3 dB power divider (ARANEN 41620) are measured. The characteristics of this divider are:

- Frequency: 0.5-3.0 GHz
- Isolation: 15 dB min.
- VSWR: 1.6 (input and output)
- Insertion loss: 0.75 dB max.
- Amplitude balance: 0.4 dB
- Phase balance: 8 degree

Since no traceable multi-port standards are available the reciprocity property of passive devices offers a good criteria solution to verify the system accuracy. Figures 2, 3 and 4 show all the reflection and transmission coefficients between the three ports of the divider. Good agreement between the measured data and the manufacturer specifications of the divider was observed. In the second test and in order to verify the time domain capability, two coupled lines with 1 mm width, 2 mm spacing and 80 mm long realized on a substrate with a relative permittivity of 3.8, was used. One port (port 1) of the coupled lines was excited by a square wave with 0.5 volt of magnitude, a frequency of 15.63 MHz and 50 per cent of duty cycle. The signals at the four ports of the lines were measured and shown in figures 5 and 6. The represented waves in the sense line describe the crosstalk effect in the two coupled line network. The frequency pulse is limited to 15.63 MHz because no higher speed pulse generator was available.

IV. CONCLUSION

A new set up for the time and frequency domain characterization of multi-port linear and non-linear microwave circuits is presented. A prototype for four port devices was designed, realized and tested. The validity of the concept and the theoretical background of the approach was demonstrated with two different test cases: frequency domain and time domain measurements. The flexibility and accuracy of this set up make it useful for digital high speed interconnections characterization and complex linear/non-linear measurement.

REFERENCES


Fig. 1: Setup for automated network analyzer for linear and nonlinear multi-port devices.
Fig. 3 Transmission coefficients between input ports (1,2) and the output (3).

Fig. 4 Isolation Between the two input ports (1,2) of the power divider. The two curves show the reciprocity of the divider as a passive three port device.

Fig. 5 Signals at the near (port 1) and far (port 4) ends of the driven line of the bus.

Fig. 6 Signals at the near (port 2) and far (port 3) ends of the sense line of the bus. The waveforms show the Crosstalk effect due to the electromagnetic coupling between the two lines.